Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
09/896,075	BAK ET AL.	
Examiner	Art Unit	
VAN H. NGUYEN	2194	

SEARCHED					
Class	Subclass	Date	Examiner		
719	310, 315	11/23/2005	VN		
717	104, 108	11/23/2005	VN		
717	116, 120	11/23/2005	VN		
717	150, 160	11/23/2005	VN		
717	165	11/23/2005	VN		
717	116,140	5/13/2006	VN		
UPDATED	ABOVE	5/13/2006	VN		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
719	315	5/13/2006	VN		
717	116, 140	5/13/2006	VN		
USPT	USPT-PGPB		VN		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
INVENTOR NAME SEARCH	11/23/2005	VN
INTERFERENCE SEARCH (SEE SEARCH HISTORY PRINTOUT)	11/23/2005	VN
INPL SEARCH (IEEE)	11/23/2005	VN
WEST (SEE SEARCH HISTORY PRINTOUT)	11/23/2005	VN
CONSULTED WITH WIL GRANT- TQAS 2100 (101 ISSUES IN CLAIMS 13, 14, AND 22-28)	11/23/2005	VN
WEST UPDATED (SEE SEARCH HISTORY PRINTOUT)	5/13/2006	VN .